Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/809,721	GROSS ET AL.	DSS ET AL.
Examiner	Art Unit	Jnit
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Method of search: EAST, YAHOO, GOOGLE, IEEE Explore, CRC	1/4/2007	E.D
Consulted: PLUS search; Deb Anjan,class 324, au: 2858	12/1/2006	E.D
Text or key word searches: see attachment.	1/4/2007	E.D